

**N - CHANNEL ENHANCEMENT MODE  
FAST POWER MOS TRANSISTOR**

PRELIMINARY DATA

| TYPE     | V <sub>DSS</sub> | R <sub>DS(on)</sub> | I <sub>D</sub> |
|----------|------------------|---------------------|----------------|
| STU6NA90 | 900 V            | < 2 Ω               | 5.8 A          |

- TYPICAL R<sub>DS(on)</sub> = 1.5 Ω
- ± 30V GATE TO SOURCE VOLTAGE RATING
- REPETITIVE AVALANCHE TESTED
- LOW INTRINSIC CAPACITANCE
- 100% AVALANCHE TESTED
- GATE CHARGE MINIMIZED
- REDUCED THRESHOLD VOLTAGE SPREAD

**DESCRIPTION**

The Max220™ package is a new high volume power package exhibiting the same footprint as the industry standard TO-220, but designed to accommodate much larger silicon chips, normally supplied in bigger packages. The increased die capacity makes the device ideal to reduce component count in multiple paralleled TO-220 designs and save board space with respect to larger packages.

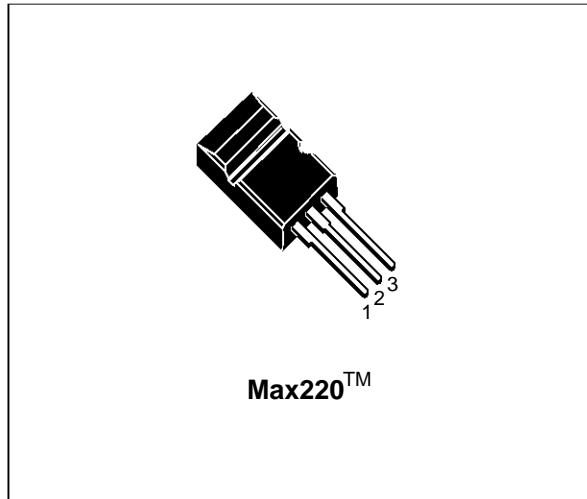
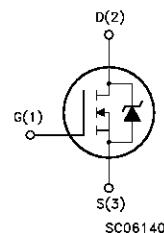
**APPLICATIONS**

- HIGH CURRENT, HIGH SPEED SWITCHING
- SWITCH MODE POWER SUPPLIES (SMPS)
- CONSUMER AND INDUSTRIAL LIGHTING
- DC-AC CONVERTERS FOR WELDING EQUIPMENT AND UNINTERRUPTIBLE POWER SUPPLIES (UPS)

**ABSOLUTE MAXIMUM RATINGS**

| Symbol             | Parameter   | Value      | Unit |
|--------------------|---|------------|------|
| V <sub>DS</sub>    | Drain-source Voltage (V <sub>GS</sub> = 0)            | 900        | V    |
| V <sub>DGR</sub>   | Drain-gate Voltage (R <sub>GS</sub> = 20 kΩ)          | 900        | V    |
| V <sub>GS</sub>    | Gate-source Voltage                                   | ± 30       | V    |
| I <sub>D</sub>     | Drain Current (continuous) at T <sub>c</sub> = 25 °C  | 5.8        | A    |
| I <sub>D</sub>     | Drain Current (continuous) at T <sub>c</sub> = 100 °C | 3.7        | A    |
| I <sub>DM(•)</sub> | Drain Current (pulsed)                                | 23.2       | A    |
| P <sub>tot</sub>   | Total Dissipation at T <sub>c</sub> = 25 °C           | 145        | W    |
|                    | Derating Factor                                       | 1.16       | W/°C |
| T <sub>stg</sub>   | Storage Temperature                                   | -65 to 150 | °C   |
| T <sub>j</sub>     | Max. Operating Junction Temperature                   | 150        | °C   |

(•) Pulse width limited by safe operating area


**INTERNAL SCHEMATIC DIAGRAM**


# STU6NA90

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## THERMAL DATA

|                       |  |     |      |      |
|-----------------------|--|-----|------|------|
| R <sub>thj-case</sub> | Thermal Resistance Junction-case               | Max | 0.86 | °C/W |
| R <sub>thj-amb</sub>  | Thermal Resistance Junction-ambient            | Max | 30   | °C/W |
| R <sub>thc-sink</sub> | Thermal Resistance Case-sink                   | Typ | 0.1  | °C/W |
| T <sub>I</sub>        | Maximum Lead Temperature For Soldering Purpose |     | 300  | °C   |

## AVALANCHE CHARACTERISTICS

| Symbol          | Parameter  | Max Value | Unit |
|-----------------|--|-----------|------|
| I <sub>AR</sub> | Avalanche Current, Repetitive or Not-Repetitive (pulse width limited by T <sub>j</sub> max, δ < 1%)                          | 6         | A    |
| E <sub>AS</sub> | Single Pulse Avalanche Energy (starting T <sub>j</sub> = 25 °C, I <sub>D</sub> = I <sub>AR</sub> , V <sub>DD</sub> = 50 V)   | 180       | mJ   |
| E <sub>AR</sub> | Repetitive Avalanche Energy (pulse width limited by T <sub>j</sub> max, δ < 1%)  | 7.2       | mJ   |
| I <sub>AR</sub> | Avalanche Current, Repetitive or Not-Repetitive (T <sub>c</sub> = 100 °C, pulse width limited by T <sub>j</sub> max, δ < 1%) | 3.8       | A    |

## ELECTRICAL CHARACTERISTICS (T<sub>case</sub> = 25 °C unless otherwise specified) OFF

| Symbol               | Parameter   | Test Conditions  | Min. | Typ. | Max.        | Unit     |
|----------------------|---|--|------|------|-------------|----------|
| V <sub>(BR)DSS</sub> | Drain-source Breakdown Voltage                        | I <sub>D</sub> = 250 μA V <sub>GS</sub> = 0  | 900  |      |             | V        |
| I <sub>DSS</sub>     | Zero Gate Voltage Drain Current (V <sub>GS</sub> = 0) | V <sub>DS</sub> = Max Rating<br>V <sub>DS</sub> = Max Rating × 0.8 T <sub>c</sub> = 125 °C |      |      | 250<br>1000 | μA<br>μA |
| I <sub>GSS</sub>     | Gate-body Leakage Current (V <sub>DS</sub> = 0)       | V <sub>GS</sub> = ± 30 V   |      |      | ± 100       | nA       |

## ON (\*)

| Symbol              | Parameter                         | Test Conditions  | Min. | Typ.     | Max.   | Unit   |
|---------------------|-----------------------------------|--|------|----------|--------|--------|
| V <sub>GS(th)</sub> | Gate Threshold Voltage            | V <sub>DS</sub> = V <sub>GS</sub> I <sub>D</sub> = 250 μA  | 2.25 | 3        | 3.75   | V      |
| R <sub>D(on)</sub>  | Static Drain-source On Resistance | V <sub>GS</sub> = 10 V I <sub>D</sub> = 3 A<br>V <sub>GS</sub> = 10 V I <sub>D</sub> = 3 A T <sub>c</sub> = 100 °C |      | 1.5<br>4 | 2<br>4 | Ω<br>Ω |
| I <sub>D(on)</sub>  | On State Drain Current            | V <sub>DS</sub> > I <sub>D(on)</sub> × R <sub>D(on)max</sub><br>V <sub>GS</sub> = 10 V                             | 6    |          |        | A      |

## DYNAMIC

| Symbol   | Parameter   | Test Conditions   | Min. | Typ.              | Max.              | Unit           |
|--|---|---|------|-------------------|-------------------|----------------|
| g <sub>fs</sub> (*)                                      | Forward Transconductance  | V <sub>DS</sub> > I <sub>D(on)</sub> × R <sub>D(on)max</sub> I <sub>D</sub> = 3 A | 5    | 6.6               |                   | S              |
| C <sub>iss</sub><br>C <sub>oss</sub><br>C <sub>rss</sub> | Input Capacitance<br>Output Capacitance<br>Reverse Transfer Capacitance | V <sub>DS</sub> = 25 V f = 1 MHz V <sub>GS</sub> = 0                              |      | 1770<br>190<br>50 | 2300<br>250<br>70 | pF<br>pF<br>pF |

**ELECTRICAL CHARACTERISTICS** (continued)  
SWITCHING ON

| Symbol                        | Parameter  | Test Conditions  | Min. | Typ.           | Max.     | Unit             |
|-------------------------------|--|--|------|----------------|----------|------------------|
| $t_{d(on)}$<br>$t_r$          | Turn-on Time<br>Rise Time                                    | $V_{DD} = 450 \text{ V}$ $I_D = 3 \text{ A}$<br>$R_G = 4.7 \Omega$ $V_{GS} = 10 \text{ V}$ |      | 27<br>30       | 40<br>45 | ns<br>ns         |
| $(di/dt)_{on}$                | Turn-on Current Slope  | $V_{DD} = 720 \text{ V}$ $I_D = 6 \text{ A}$<br>$R_G = 47 \Omega$ $V_{GS} = 10 \text{ V}$  |      | 110            |          | A/ $\mu\text{s}$ |
| $Q_g$<br>$Q_{gs}$<br>$Q_{gd}$ | Total Gate Charge<br>Gate-Source Charge<br>Gate-Drain Charge | $V_{DD} = 720 \text{ V}$ $I_D = 6 \text{ A}$ $V_{GS} = 10 \text{ V}$                       |      | 72<br>10<br>34 | 105      | nC<br>nC<br>nC   |

## SWITCHING OFF

| Symbol                          | Parameter   | Test Conditions  | Min. | Typ.          | Max.           | Unit           |
|---------------------------------|---|--|------|---------------|----------------|----------------|
| $t_{r(Voff)}$<br>$t_f$<br>$t_c$ | Off-voltage Rise Time<br>Fall Time<br>Cross-over Time | $V_{DD} = 720 \text{ V}$ $I_D = 6 \text{ A}$<br>$R_G = 4.7 \Omega$ $V_{GS} = 10 \text{ V}$ |      | 18<br>7<br>31 | 27<br>12<br>47 | ns<br>ns<br>ns |

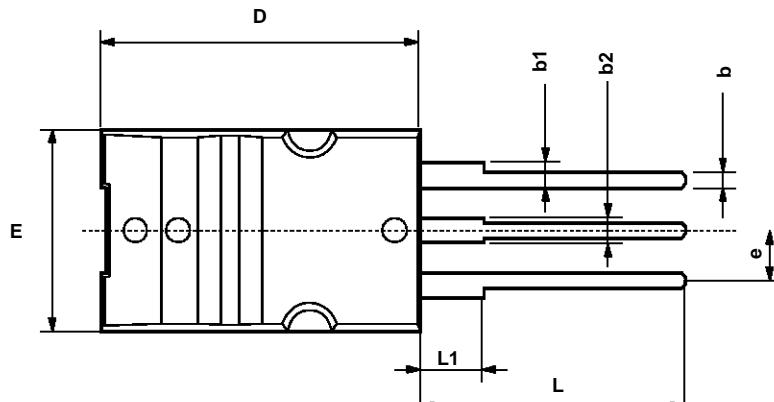
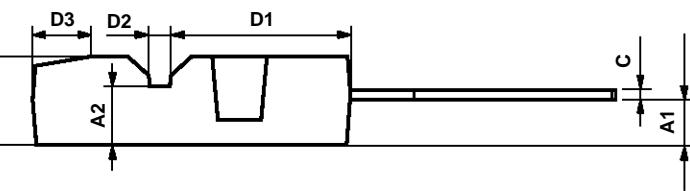
## SOURCE DRAIN DIODE

| Symbol                            | Parameter  | Test Conditions  | Min. | Typ.              | Max.        | Unit                     |
|-----------------------------------|--|--|------|-------------------|-------------|--------------------------|
| $I_{SD}$<br>$I_{SDM}(\bullet)$    | Source-drain Current<br>Source-drain Current (pulsed)                        |  |      |                   | 5.8<br>23.2 | A<br>A                   |
| $V_{SD} (\ast)$                   | Forward On Voltage   | $I_{SD} = 6 \text{ A}$ $V_{GS} = 0$  |      |                   | 1.6         | V                        |
| $t_{rr}$<br>$Q_{rr}$<br>$I_{RRM}$ | Reverse Recovery Time<br>Reverse Recovery Charge<br>Reverse Recovery Current | $I_{SD} = 6 \text{ A}$ $di/dt = 100 \text{ A}/\mu\text{s}$<br>$V_{DD} = 100 \text{ V}$ $T_j = 150^\circ\text{C}$ |      | 830<br>13.7<br>33 |             | ns<br>$\mu\text{C}$<br>A |

(\ast) Pulsed: Pulse duration = 300  $\mu\text{s}$ , duty cycle 1.5 %

(\bullet) Pulse width limited by safe operating area

| Max220 MECHANICAL DATA |       |      |       |       |       |       |
|------------------------|-------|------|-------|-------|-------|-------|
| DIM.                   | mm    |      |       | inch  |       |       |
|                        | MIN.  | TYP. | MAX.  | MIN.  | TYP.  | MAX.  |
| A                      | 4.3   |      | 4.6   | 0.169 |       | 0.181 |
| A1                     | 2.2   |      | 2.4   | 0.087 |       | 0.094 |
| A2                     | 2.9   |      | 3.1   | 0.114 |       | 0.122 |
| b                      | 0.7   |      | 0.93  | 0.027 |       | 0.036 |
| b1                     | 1.25  |      | 1.4   | 0.049 |       | 0.055 |
| b2                     | 1.2   |      | 1.38  | 0.047 |       | 0.054 |
| c                      | 0.45  |      | 0.6   |       | 0.18  | 0.023 |
| D                      | 15.9  |      | 16.3  |       | 0.626 | 0.641 |
| D1                     | 9     |      | 9.35  | 0.354 |       | 0.368 |
| D2                     | 0.8   |      | 1.2   | 0.031 |       | 0.047 |
| D3                     | 2.8   |      | 3.2   | 0.110 |       | 0.126 |
| e                      | 2.44  |      | 2.64  | 0.096 |       | 0.104 |
| E                      | 10.05 |      | 10.35 | 0.396 |       | 0.407 |
| L                      | 13.2  |      | 13.6  | 0.520 |       | 0.535 |
| L1                     | 3     |      | 3.4   | 0.118 |       | 0.133 |



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